

Notice of References Cited	Application/Control No. 10/618,446		Applicant(s)/Patent Under Reexamination MACGIBBON ET AL.	
	Examiner Michael P. Stafira		Art Unit 2877	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0080346	06-2002	Vaez-Iravani et al.	356/237.2
	B	US-2002/0145732	10-2002	Vaez-Iravani et al.	356/237.2
	C	US-2003/0210393	11-2003	Vaez-Iravani et al.	356/237.4
	D	US-6,707,056	03-2004	Fanton et al.	250/559.44
	E	US-2003/0156280	08-2003	Reinhorn, Silviu	356/237.2
	F	US-2004/0012775	01-2004	Kinney et al.	356/237.2
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tetsuya Kawanishi "Brewster's scattering angle and quasi-anomalous scattering in random scattering from dielectric interfaces" Optical Society of America , Vol. 16, No. 2, Feb. 1999.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.